TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VHC574F,TC74VHC574FT,TC74VHC574FK

Octal D-Type Flip Flop with 3-State Output

The TC74VHC574 is advanced high speed CMOS OCTAL FLIP-FLOP with 3-STATE OUTPUT fabricated with silicon gate C²MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

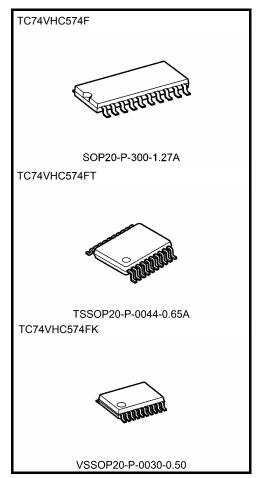
This 8-bit D-type flip-flop is controlled by a clock input (CK) and an output enable input (\overline{OE}).

When the \overline{OE} input is high, the eight outputs are in a high impedance state.

An input protection circuit ensures that 0 to 5.5~V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5~V to 3~V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

Features

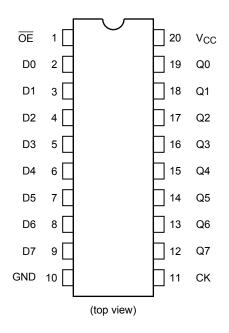
- High speed: $f_{max} = 180 \text{ MHz}$ (typ.) at $V_{CC} = 5 \text{ V}$
- Low power dissipation: $I_{CC} = 4 \mu A \text{ (max)}$ at $T_{a} = 25 \text{°C}$
- High noise immunity: $V_{NIH} = V_{NIL} = 28\% V_{CC}$ (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays: $t_{pLH} \simeq t_{pHL}$
- Wide operating voltage range: $V_{CC \text{ (opr)}} = 2 \text{ to } 5.5 \text{ V}$
- Low noise: VOLP = 1.2 V (max)
- Pin and function compatible with 74ALS574



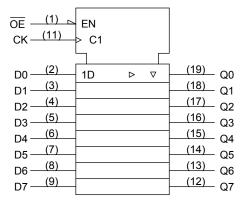
Weight

SOP20-P-300-1.27A : 0.22 g (typ.) TSSOP20-P-0044-0.65A : 0.08 g (typ.) VSSOP20-P-0030-0.50 : 0.03 g (typ.)

Pin Assignment



IEC Logic Symbol



Truth Table

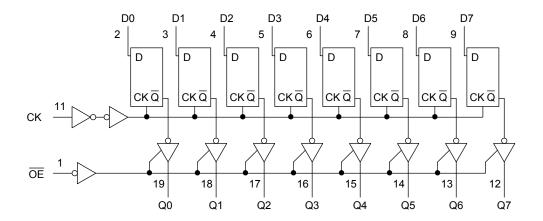
	Inputs		Output
ŌE	СК	D	Output
Н	Х	Χ	Z
L	\neg	Х	Qn
L		L	L
L		Н	Н

X: Don't care

Z: High impedance

Q_n: No change

System Diagram





Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC}	−0.5 to 7.0	V
DC input voltage	V _{IN}	−0.5 to 7.0	V
DC output voltage	V _{OUT}	-0.5 to V _{CC} + 0.5	V
Input diode current	I _{IK}	-20	mA
Output diode current	lok	±20	mA
DC output current	lout	±25	mA
DC V _{CC} /ground current	Icc	±75	mA
Power dissipation	PD	180	mW
Storage temperature	T _{stg}	−65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Operating Ranges (Note)

Characteristics	Symbol	Rating	Unit	
Supply voltage	V _{CC}	2.0 to 5.5	V	
Input voltage	V_{IN}	0 to 5.5	>	
Output voltage	V _{OUT}	0 to V _{CC}	V	
Operating temperature	T _{opr}	−40 to 85	°C	
Input rise and fall time	dt/dv	0 to 100 (V _{CC} = 3.3 ± 0.3 V)	ns/V	
input rise and fail tille	ui/uv	0 to 20 (V _{CC} = 5 ± 0.5 V)	ns/V	

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

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Electrical Characteristics

DC Characteristics

Characteristics	Symbol	Test Condition			Ta = 25°C			Ta = -40 to 85°C		Unit
		V		V _{CC} (V)	Min	Тур.	Max	Min	Max	
High-level input voltage	V _{IH}		_	2.0 3.0 to	1.50 V _{CC} ×	_	_	1.50 V _{CC} ×		V
				5.5	0.7			0.7		
Low-level input				2.0	_	_	0.50	_	0.50	
voltage	V_{IL}		_	3.0 to 5.5	_	ı	V _{CC} × 0.3	ı	V _{CC} × 0.3	V
				2.0	1.9	2.0	_	1.9	_	
			I _{OH} = -50 μA	3.0	2.9	3.0	_	2.9	_	
High-level output voltage	V _{ОН}	VIN = VIH or VIL		4.5	4.4	4.5	_	4.4	_	V
Ü			I _{OH} = -4 mA	3.0	2.58	_	_	2.48	_	
			I _{OH} = −8 mA	4.5	3.94	_	_	3.80	_	
	V _{OL}	V _{IN} = V _{IH} or V _{IL}		2.0	_	0.0	0.1	_	0.1	V
			I _{OL} = 50 μA	3.0	_	0.0	0.1	_	0.1	
Low-level output voltage				4.5	_	0.0	0.1	1	0.1	
			I _{OL} = 4 mA	3.0	_	_	0.36	_	0.44	
			I _{OL} = 8 mA	4.5	_	-	0.36	1	0.44	
3-state output off-state current	I _{OZ}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = V_{CC} \text{ or GND}$		5.5	_	-	±0.25	-	±2.50	μΑ
Input leakage current	I _{IN}	V _{IN} = 5.5 V or GND		0 to 5.5	_	_	±0.1	_	±1.0	μΑ
Quiescent supply current	Icc	V _{IN} = V _{CC} or	r GND	5.5	_	_	4.0	_	40.0	μΑ

Timing Requirements (input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol	Test Condition	Ta = 25°C		Ta = -40 to 85°C	Unit	
			V _{CC} (V)	Тур.	Limit	Limit	
Minimum pulse width	t _{w (H)}		3.3 ± 0.3	_	5.0	5.0	20
(CK)	t _{w (L)}	_	5.0 ± 0.5	_	5.0	5.0	ns
Minimum act un timo	+		3.3 ± 0.3	_	3.5	3.5	no
Minimum set-up time	t _S	_	5.0 ± 0.5	_	3.5	3.5	ns
Minimum hold time	t _h		3.3 ± 0.3	_	1.5	1.5	no
		_	5.0 ± 0.5	_	1.5	1.5	ns



AC Characteristics (input: $t_r = t_f = 3$ ns)

Characteristics Symbol	Symbol	Test Condition		Ta = 25°C			Ta = -40 to 85°C		Unit	
	-,		V _{CC} (V)	C _L (pF)	Min	Тур.	Max	Min	Max	
			3.3 ± 0.3	15	_	8.5	13.2	1.0	15.5	ns
Propagation delay time	t_{pLH}	_	3.3 ± 0.5	50	1	11.0	16.7	1.0	19.0	
(CK-Q)	t_{pHL}		5.0 ± 0.5	15	1	5.6	8.6	1.0	10.0	110
			3.0 ± 0.3	50	1	7.1	10.6	1.0	12.0	
			3.3 ± 0.3	15	-	8.2	12.8	1.0	15.0	
3-state output enable	t_{pZL}	$R_{l} = 1 k\Omega$	0.0 ± 0.0	50	1	10.7	16.3	1.0	18.5	ns
time	t_{pZH}	NL - 1 K12	5.0 ± 0.5	15	1	5.9	9.0	1.0	10.5	-
				50	I	7.4	11.0	1.0	12.5	
3-state output disable	t_{pLZ}	R _L = 1 kΩ	3.3 ± 0.3	50	ı	11.0	15.0	1.0	17.0	ns
time	t_{pHZ}		5.0 ± 0.5	50	_	7.1	10.1	1.0	11.5	
	f _{max}	-	3.3 ± 0.3	15	80	125	_	65	_	- MHz
Maximum clock				50	50	75	_	45	_	
frequency			5.0 ± 0.5	15	130	180	_	110	_	
				50	85	115	_	75	_	
Output to output skew	t _{osLH}	(Note 1)	3.3 ± 0.3	50	1	_	1.5	_	1.5	ns
Output to output skew	t_{osHL}	(Note 1)	5.0 ± 0.5	50	_	_	1.0	_	1.0	
Input capacitance	C _{IN}				_	4	10		10	pF
Output capacitance	C _{OUT}		_			6	_	_	_	pF
Power dissipation capacitance	C _{PD}			(Note 2)		28	_	_	_	pF

Note 1: Parameter guaranteed by design.

 $t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|$

Note 2: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

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Average operating current can be obtained by the equation:

$$I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 (per F/F)$$

And the total CPD when n pcs. of latch operate can be gained by the following equation:

C_{PD} (total) = 20 + 8·n

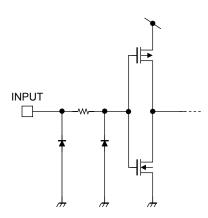


Noise Characteristics (input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol	Test Condition	Ta =	- Unit		
Characteristics	Symbol		V _{CC} (V)	Тур.	Max	Offic
Quiet output maximum dynamic V _{OL}	V_{OLP}	C _L = 50 pF	5.0	0.8	1.0	V
Quiet output minimum dynamic V _{OL}	V _{OLV}	C _L = 50 pF	5.0	-0.8	-1.0	V
Minimum high level dynamic input voltage	V_{IHD}	C _L = 50 pF	5.0	_	3.5	V
Maximum low level dynamic input voltage	V _{ILD}	C _L = 50 pF	5.0	_	1.5	V

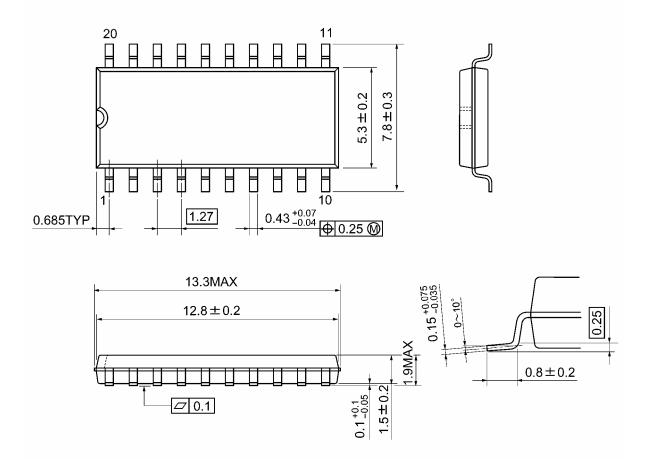
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Input Equivalent Circuit



Package Dimensions

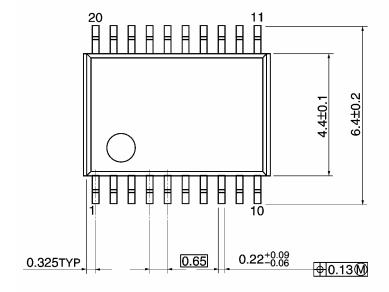
SOP20-P-300-1.27A Unit: mm

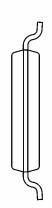


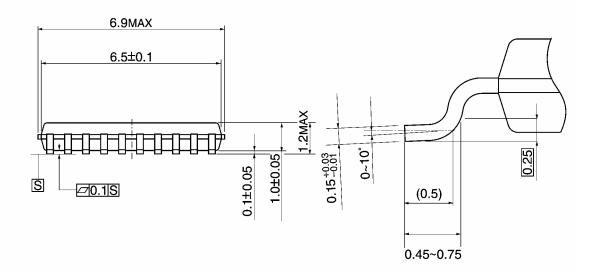
Weight: 0.22 g (typ.)

Package Dimensions

TSSOP20-P-0044-0.65A Unit: mm





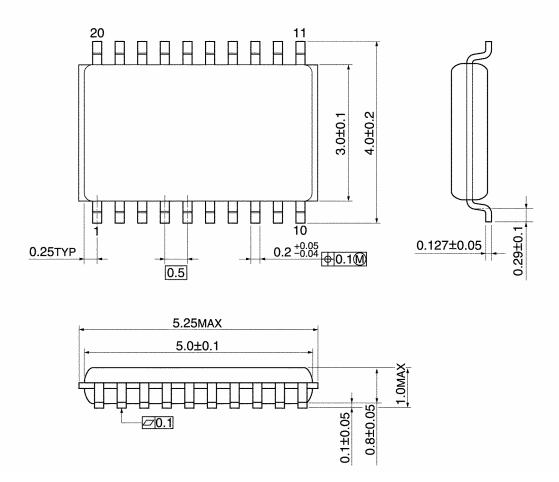


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Weight: 0.08 g (typ.)

Package Dimensions

VSSOP20-P-0030-0.50 Unit: mm



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Weight: 0.03 g (typ.)

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20070701-EN GENERAL

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